



# DIM1500ESM33-MF000

# **Single Switch IGBT Module**

Replaces DS6242-4

DS6242-5 April 2019 (LN38039)

## **FEATURES**

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Soft Punch Through Silicon
- High Current Density Enhanced DMOS SPT
- Isolated AISiC Base With AIN Substrates

## **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM1500ESM33-MF000 is a single switch 3300V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

## **ORDERING INFORMATION**

Order As:

## DIM1500ESM33-MF000

Note: When ordering, please use the complete part number

#### **KEY PARAMETERS**

V <sub>CES</sub>		3300V
V <sub>CE(sat)</sub>	* (typ)	3.3V
l <sub>c</sub> ` ´	(max)	1500A
I <sub>C(PK)</sub>	(max)	3000A

\* Measured at the auxiliary terminals

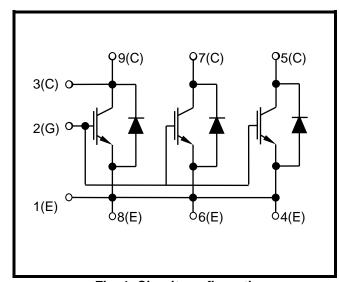


Fig. 1 Circuit configuration

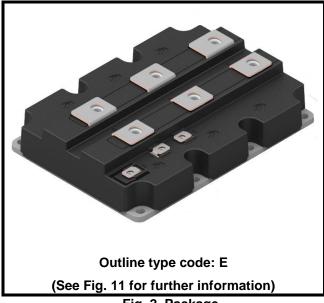


Fig. 2 Package



## **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	V <sub>GE</sub> = 0V	3300	V
$V_{GES}$	Gate-emitter voltage		±20	V
I <sub>C</sub>	Continuous collector current	T <sub>case</sub> = 108°C	1500	Α
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 136°C	3000	Α
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	17.9	kW
l <sup>2</sup> t	Diode I <sup>2</sup> t value	$V_R = 0$ , $t_p = 10$ ms, $T_j = 150$ °C	720	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	6000	V
$Q_{PD}$	Partial discharge – per module	IEC1287, V <sub>1</sub> = 3500V, V <sub>2</sub> = 2600V, 50Hz RMS	10	рC

## THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

33mm

20mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	7	°C/kW
$R_{\text{th(j-c)}}$	Thermal resistance – diode	Continuous dissipation - junction to case	-	ı	12	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	1	6	°C/kW
_	Junction temperature	Transistor	-	-	150	°C
T <sub>j</sub>		Diode	-	-	150	°C
T <sub>stg</sub>	Storage temperature range	-	-40		150	°C
		Mounting – M6	-	ı	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm



## **ELECTRICAL CHARACTERISTICS**

 $T_{case}$  = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V$ , $V_{CE} = V_{CES}$			5	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 125$ °C			90	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 150$ °C			150	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			1	μΑ
$V_{\text{GE(TH)}}$	Gate threshold voltage	$I_C = 120$ mA, $V_{GE} = V_{CE}$		6.0		V
		$V_{GE} = 15V, I_C = 1500A$		3.3		V
$V_{\text{CE(sat)}}$	Collector-emitter saturation voltage	$V_{GE} = 15V$ , $I_C = 1500A$ , $T_j = 125$ °C				V
	G	$V_{GE} = 15V$ , $I_C = 1500A$ , $T_j = 150$ °C		4.0		V
I <sub>F</sub>	Diode forward current	DC		1500		Α
I <sub>FM</sub>	Diode maximum forward current	$t_p = 1 ms$		3000		Α
	Diode forward voltage	I <sub>F</sub> = 1500A		1.8		V
$V_{F}$		$I_F = 1500A, T_j = 125^{\circ}C$		1.9		V
		I <sub>F</sub> = 1500A, T <sub>j</sub> = 150°C		1.9		V
C <sub>ies</sub>	Input capacitance	$V_{CE} = 25V$ , $V_{GE} = 0V$ , $f = 100kHz$		140		nF
$Q_g$	Gate charge	±15V		13		μC
$C_{res}$	Reverse transfer capacitance	$V_{CE} = 25V$ , $V_{GE} = 0V$ , $f = 100kHz$		4.5		nF
L <sub>M</sub>	Module inductance			6		nΗ
R <sub>INT</sub>	Internal transistor resistance			70		μΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	$T_{j} = 150^{\circ}\text{C}, \ V_{CC} = 2500\text{V}$ $t_{p} \le 10\mu\text{s}, \ V_{GE} \le 15\text{V}$ $V_{CE \ (max)} = V_{CES} - L^{*} x \ dl/dt$ IEC 60747-9		6000		А

#### Note

L is the circuit inductance +  $L_{\rm M}$ 



## **ELECTRICAL CHARACTERISTICS**

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 1500A		1680		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		290		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		1100		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 1.8\Omega$ $R_{g(OFF)} = 1.8\Omega$		760		ns
t <sub>r</sub>	Rise time	$C_{GE} = 330$ nF $L_S \sim 150$ nH		360		ns
E <sub>ON</sub>	Turn-on energy loss			1800		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 1500A		1000		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 1800V		1750		Α
E <sub>rec</sub>	Diode reverse recovery energy	$dI_F/dt = 4000A/\mu s$		1050		mJ

## T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 1500A		1790		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		360		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		1690		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 1.8\Omega$ $R_{g(OFF)} = 1.8\Omega$ $C_{GE} = 330 nF$ $L_{S} \sim 150 nH$		700		ns
t <sub>r</sub>	Rise time			180		ns
E <sub>ON</sub>	Turn-on energy loss			3090		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 1500A		1540		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 1800V		1810		Α
E <sub>rec</sub>	Diode reverse recovery energy	$dI_F/dt = 4000A/\mu s$		1490		mJ

# $T_{case}$ = 150°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 1500A		1800		ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$		1040		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 1800V$		1880		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{g(ON)} = 1.8\Omega$ $R_{g(OFF)} = 1.8\Omega$		740		ns
t <sub>r</sub>	Rise time	$C_{GE} = 330 \text{nF}$ $L_S \sim 150 \text{nH}$		450		ns
E <sub>ON</sub>	Turn-on energy loss			3400		mJ
$Q_{rr}$	Diode reverse recovery charge	I <sub>F</sub> = 1500A		1820		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> = 1800V		1910		Α
E <sub>rec</sub>	Diode reverse recovery energy	$dI_F/dt = 4000A/\mu s$		1790		mJ



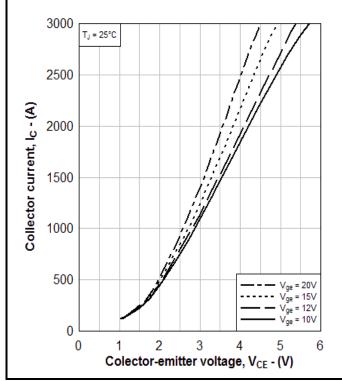


Fig. 3 Typical output characteristics

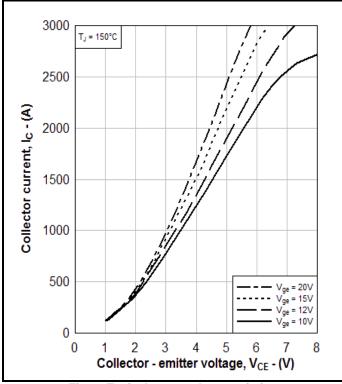


Fig. 4 Typical output characteristics

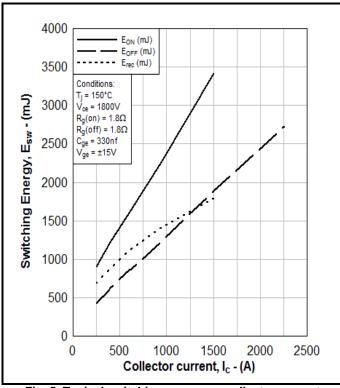


Fig. 5 Typical switching energy vs collector current

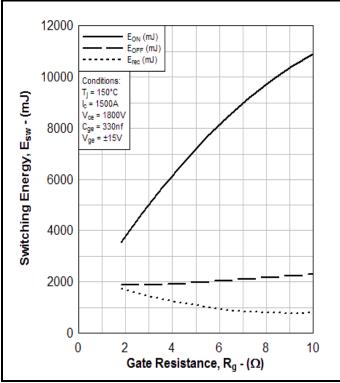


Fig. 6 Typical switching energy vs gate resistance



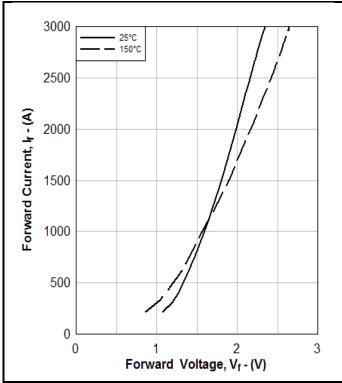


Fig. 7 Diode typical forward characteristics

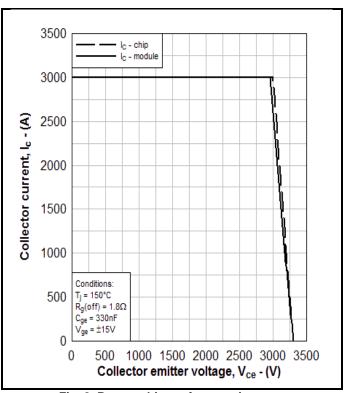


Fig. 8 Reverse bias safe operating area

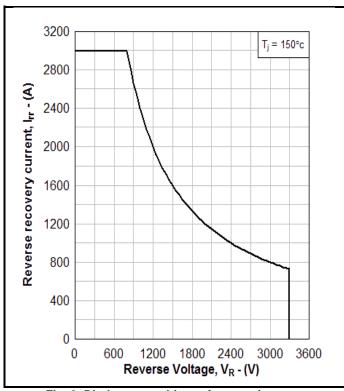


Fig. 9 Diode reverse bias safe operating area

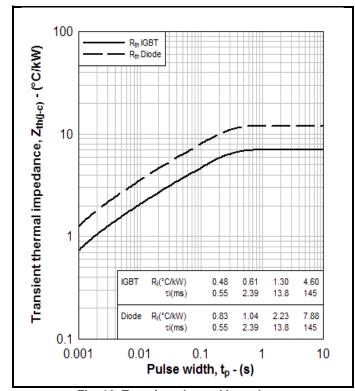


Fig. 10 Transient thermal impedance



## **PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

## DO NOT SCALE.

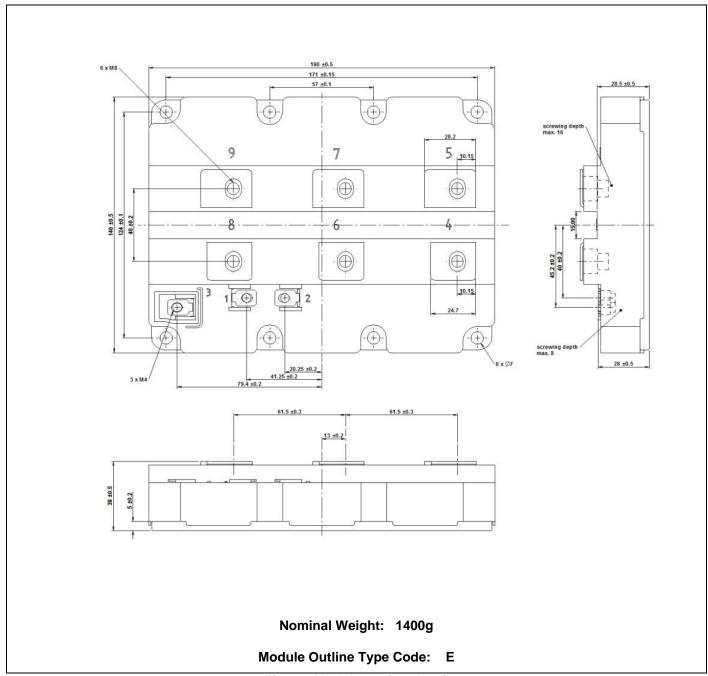


Fig. 11 Module outline drawing



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